


<b>Search Notes</b>  	<b>Application/Control No.</b>  10688628	<b>Applicant(s)/Patent Under Reexamination</b>  AGURA ET AL.
	<b>Examiner</b>  Shin, Min	<b>Art Unit</b>  3688

SEARCHED			
Class	Subclass	Date	Examiner
705	14	6/3/2009	MS

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search (USPAT US PgPub, EPO, JPO, DERWENT, IBM TB) (attached)	9/26/07	JWM
EAST Search (USPAT US PgPub, EPO, JPO, DERWENT, IBM TB) (attached)	6/3/2009	MS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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